FAIRCHILD

SEMICONDUCTOR

September 2009

FDMS7660AS N-Channel PowerTrench[®] SyncFETTM 30 V, 42 A, 2.4 m Ω

Features

- Max $r_{DS(on)}$ = 2.4 m Ω at V_{GS} = 10 V, I_D = 25 A
- Max $r_{DS(on)}$ = 2.6 m Ω at V_{GS} = 7 V, I_D = 23 A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- SyncFET Schottky Body Diode
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

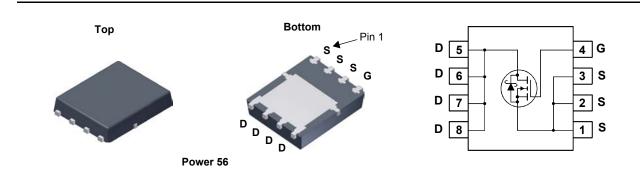


General Description

The FDMS7660AS has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance. This device has the added benefit of an efficient monolithic Schottky body diode.

Applications

- Synchronous Rectifier for DC/DC Converters
- Notebook Vcore/ GPU low side switch
- Networking Point of Load low side switch
- Telecom secondary side rectification



MOSFET Maximum Ratings T_C = 25 °C unless otherwise noted

Symbol	Parameter			Ratings	Units
V _{DS}	Drain to Source Voltage			30	V
V _{GS}	Gate to Source Voltage		(Note 4)	±20	V
ID	Drain Current -Continuous (Package limited)	T _C = 25 °C		42	
	-Continuous (Silicon limited)	T _C = 25 °C		152	A
	-Continuous	T _A = 25 °C	(Note 1a)	26	A
	-Pulsed			150	
dv/dt	MOSFET dv/dt			1.7	V/ns
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	128	mJ
P _D	Power Dissipation	T _C = 25 °C		83	w
	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case		1.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (N	Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS7660AS	FDMS7660AS	Power 56	13 "	12 mm	3000 units

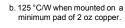
Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units	
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 1 mA, V _{GS} = 0 V				V	
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	I_D = 10 mA, referenced to 25 °C		14		mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			500	μA	
I _{GSS}	Gate to Source Leakage Current, Forward	V_{GS} = 20 V, V_{DS} = 0 V			100	nA	
On Chara	cteristics (Note 2)						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	1.2	1.9	3.0	V	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 10 mA, referenced to 25 °C		-5		mV/°C	
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 25 A		1.9	2.4		
		V _{GS} = 7 V, I _D = 23 A		2.0	2.6		
		V _{GS} = 4.5 V, I _D = 21 A	2.5 3.0		mΩ		
		V _{GS} = 10 V, I _D = 25 A, T _J = 125 °C		2.4	3.1		
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 25 A		455		S	
Dynamic	Characteristics						
C _{iss}	Input Capacitance	V 45.V.V 6.V		4600	6120	pF	
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		1550	2065	pF	
C _{rss}	Reverse Transfer Capacitance			125	190	pF	
R _g	Gate Resistance			0.8	1.7	Ω	
Switching	g Characteristics						
t _{d(on)}	Turn-On Delay Time			19	34	ns	
t _r	Rise Time	V _{DD} = 15 V, I _D = 25 A, V _{GS} = 10 V, R _{GEN} = 6 Ω		8	15	ns	
t _{d(off)}	Turn-Off Delay Time			40	65	ns	
t _f	Fall Time	1 1		5	10	ns	
Q _q	Total Gate Charge	V _{GS} = 0 V to 10 V		64	90	nC	
Q _g	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} \text{ V}_{DD} = 15 \text{ V},$		29	42	nC	
Q _{gs}	Gate to Source Gate Charge	I _D = 25 A		14.4		nC	
Q _{gd}	Gate to Drain "Miller" Charge			5.9		nC	
*	Irce Diode Characteristics	· · · · ·		I	r	-1	
	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 2 A$ (Note 2)		0.41	0.7		
V _{SD}		$V_{GS} = 0 V, I_S = 25 A$ (Note 2)		0.76	1.2	V	
t _{rr}	Reverse Recovery Time			39	62	ns	
	·····	I _F = 25 A, di/dt = 300 A/μs		55		nC	

 Q_{rr} Notes:

1. $R_{\theta,JR}$ is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta,JC}$ is guaranteed by design while $R_{\theta,CA}$ is determined by the user's board design.



a. 50 °C/W when mounted on a 1 in² pad of 2 oz copper.





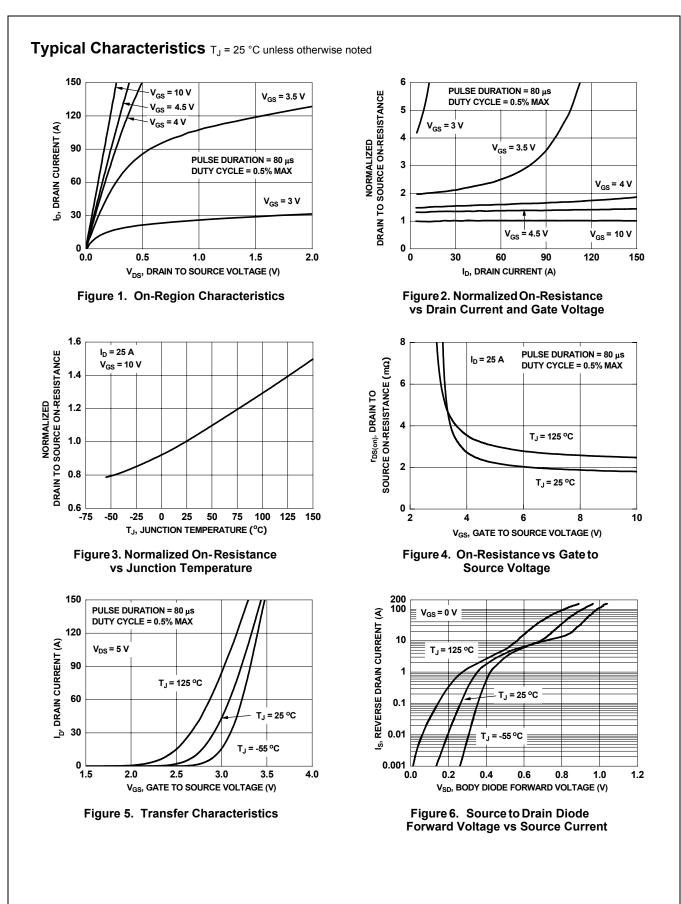
2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

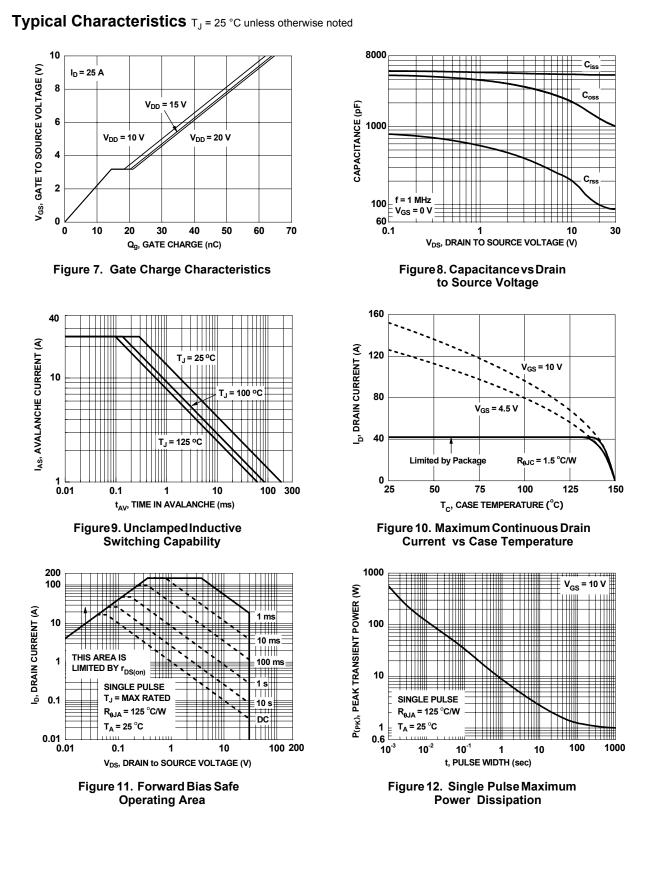
3. E_{AS} of 128 mJ is based on starting T_J = 25 °C, L = 1 mH, I_{AS} = 16 A, V_{DD} = 27 V, V_{GS} = 10 V. 100% test at L = 0.3 mH, I_{AS} = 25 A.

4. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

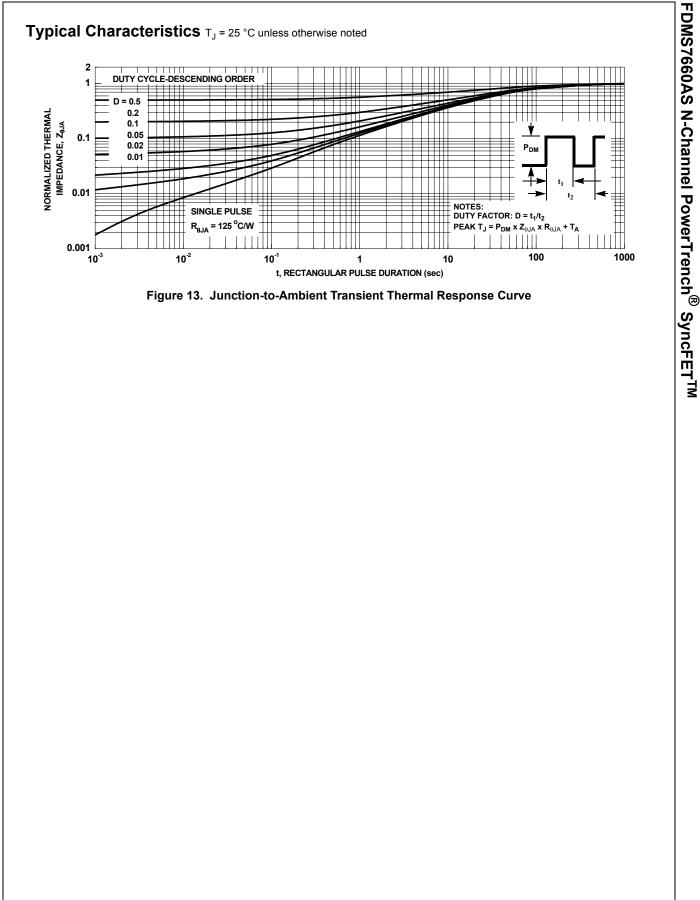
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Typical Characteristics (continued)

SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MoSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverses recovery characteristic of the FDMS7660AS.

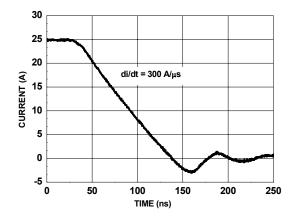


Figure 14. FDMS7660AS SyncFET body diode reverse recovery characteristic

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

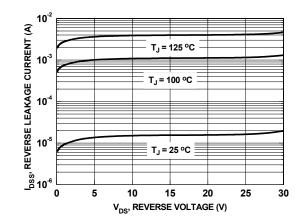
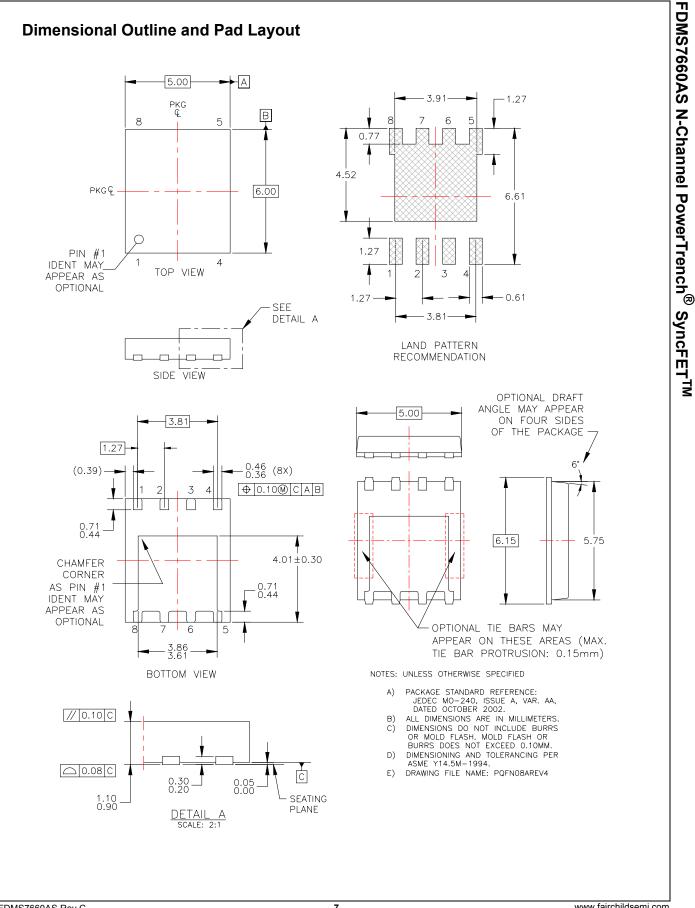
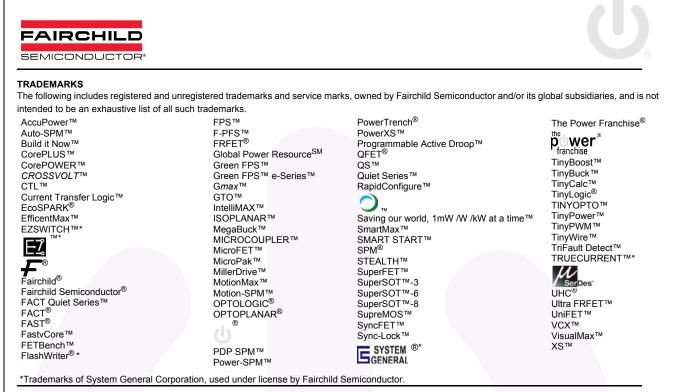


Figure 15. SyncFET body diode reverses leakage versus drain-source voltage



FDMS7660AS Rev.C



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